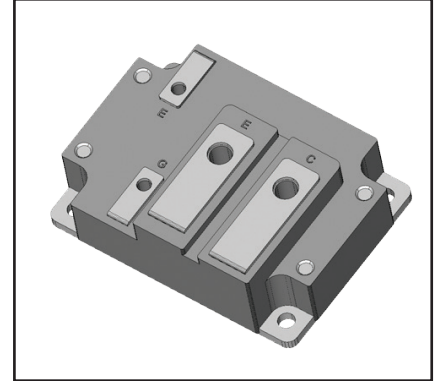
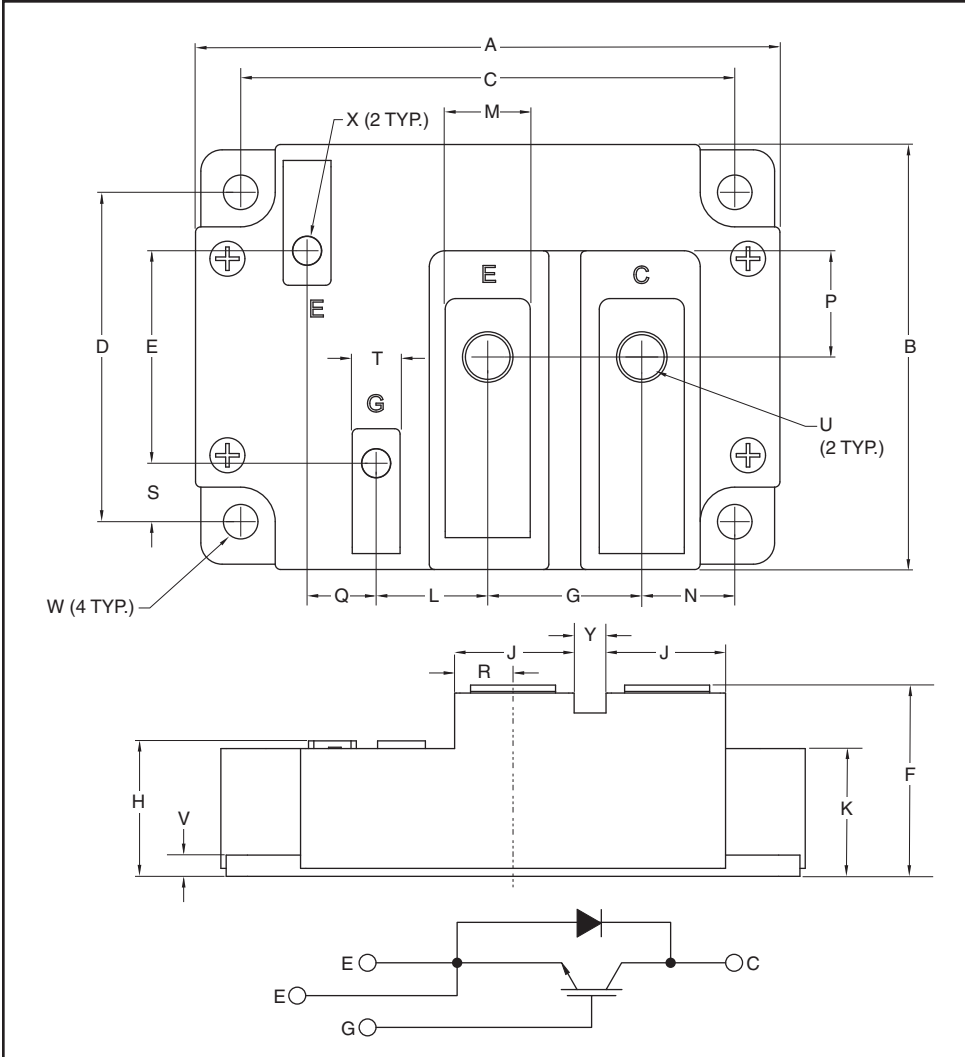


Single IGBT Module 600 Amperes/1700 Volts

Note: All electrical characteristics scaled from 300A module CM300DX-34SA.



Description:

Powerex IGBT Modules are designed for use in switching applications. Each module consists of one IGBT Transistor in a single configuration with a reverse-connected super-fast recovery free-wheel diode. All components and interconnects are isolated from the heat sinking baseplate, offering simplified system assembly and thermal management.

Features:

- Low Drive Power
- Low $V_{CE(sat)}$
- Discrete Super-Fast Recovery Free-Wheel Diode
- Isolated Baseplate for Easy Heat Sinking

Applications:

- AC Motor Control
- Motion/Servo Control
- UPS
- Welding Power Supplies
- Laser Power Supplies

Outline Drawing and Circuit Diagram

Dimensions	Inches	Millimeters
A	4.33	110.0
B	3.15	80.0
C	3.66±0.008	93.0±0.25
D	2.44±0.008	62.0±0.25
E	1.57	40.0
F	1.42 Max.	36.0 Max.
G	1.14	29.0
H	1.00 Max.	25.5 Max.
J	0.89	22.5
K	0.93	23.5
L	0.83	21.0
M	0.63	16.0

Dimensions	Inches	Millimeters
N	0.69	17.5
P	0.79	20.0
Q	0.51	13.0
R	0.43	11.0
S	0.43	11.0
T	0.35	9.0
U	M8 Metric	M8
V	0.16	4.0
W	0.256 Dia.	6.5 Dia.
X	M4 Metric	M4
Y	0.24	6.0

QIS1760002
Single IGBT Module
 600 Amperes/1700 Volts

Absolute Maximum Ratings, $T_j = 25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbol	Rating	Units
Collector-Emitter Voltage ($V_{GE} = 0\text{V}$)	V_{CES}	1700	Volts
Gate-Emitter Voltage ($V_{CE} = 0\text{V}$)	V_{GES}	± 20	Volts
Collector Current (DC, $T_C = \text{TBD}^\circ\text{C}$)*2,*4	I_C	600	Amperes
Collector Current (Pulse, Repetitive)*3	I_{CRM}	1200	Amperes
Total Power Dissipation ($T_C = 25^\circ\text{C}$)*2,*4	P_{tot}	4660	Watts
Emitter Current ($T_C = \text{TBD}^\circ\text{C}$)*2,*4	I_E^{*1}	600	Amperes
Emitter Current (Pulse, Repetitive)*3	I_{ERM}^{*1}	1200	Amperes
Maximum Junction Temperature	$T_{j(\max)}$	175	$^\circ\text{C}$
Maximum Case Temperature*2	$T_{C(\max)}$	125	$^\circ\text{C}$
Operating Junction Temperature	$T_{j(\text{op})}$	-40 to +150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-40 to +125	$^\circ\text{C}$
Isolation Voltage (Terminals to Baseplate, RMS, $f = 60\text{Hz}$, AC 1 minute)	V_{ISO}	3500	Volts

*1 Represent ratings and characteristics of the anti-parallel, emitter-to-collector free wheeling diode (FWDI).

*2 Case temperature (T_C) and heatsink temperature (T_S) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. The heatsink thermal resistance should be measured just under the chips.

*3 Pulse width and repetition rate should be such that device junction temperature (T_j) does not exceed $T_{j(\max)}$ rating.

*4 Junction temperature (T_j) should not increase beyond maximum junction temperature ($T_{j(\max)}$) rating.

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Single IGBT Module
 600 Amperes/1700 Volts

Electrical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Collector-Emitter Cutoff Current	I_{CES}	$V_{CE} = V_{CES}, V_{GE} = 0V$	—	—	2	mA
Gate-Emitter Leakage Current	I_{GES}	$V_{GE} = V_{GES}, V_{CE} = 0V$	—	—	1.0	μA
Gate-Emitter Threshold Voltage	$V_{GE(th)}$	$I_C = 60\text{mA}, V_{CE} = 10V$	5.4	6.0	6.6	Volts
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 600\text{A}, V_{GE} = 15V, T_j = 25^\circ\text{C}^{*6}$	—	2.0	2.5	Volts
		$I_C = 600\text{A}, V_{GE} = 15V, T_j = 125^\circ\text{C}^{*6}$	—	2.2	—	Volts
		$I_C = 600\text{A}, V_{GE} = 15V, T_j = 150^\circ\text{C}^{*6}$	—	2.25	—	Volts
Input Capacitance	C_{ies}		—	—	104	nF
Output Capacitance	C_{oes}	$V_{CE} = 10V, V_{GE} = 0V$	—	—	4.4	nF
Reverse Transfer Capacitance	C_{res}		—	—	1.04	nF
Gate Charge	Q_G	$V_{CC} = 1000V, I_C = 600A, V_{GE} = 15V$	—	3312	—	nC
Turn-on Delay Time	$t_{d(on)}$		—	TBD	—	ns
Rise Time	t_r	$V_{CC} = 1000V, I_C = 600A, V_{GE} = \pm 15V,$	—	TBD	—	ns
Turn-off Delay Time	$t_{d(off)}$	$R_G = 0\Omega, \text{ Inductive Load}$	—	TBD	—	ns
Fall Time	t_f		—	TBD	—	ns
Emitter-Collector Voltage	V_{EC}^{*1}	$I_E = 600A, V_{GE} = 0V, T_j = 25^\circ\text{C}^{*6}$	—	4.1	5.3	Volts
		$I_E = 600A, V_{GE} = 0V, T_j = 125^\circ\text{C}^{*6}$	—	2.9	—	Volts
		$I_E = 600A, V_{GE} = 0V, T_j = 150^\circ\text{C}^{*6}$	—	2.7	—	Volts
Reverse Recovery Time	t_{rr}^{*1}	$V_{CC} = 1000V, I_E = 600A, V_{GE} = \pm 15V$	—	—	300	ns
Reverse Recovery Charge	Q_{rr}^{*1}	$R_G = 0\Omega, \text{ Inductive Load}$	—	28	—	μC
Turn-on Switching Energy per Pulse	E_{on}	$V_{CC} = 1000V, I_C = I_E = 600A,$	—	76	—	mJ
Turn-off Switching Energy per Pulse	E_{off}	$V_{GE} = \pm 15V, R_G = 0\Omega,$	—	160	—	mJ
Reverse Recovery Energy per Pulse	E_{rr}^{*1}	$T_j = 150^\circ\text{C}, \text{ Inductive Load}$	—	138	—	mJ
Internal Lead Resistance	$R_{CC} + EE'$	Main Terminals-Chip, $T_C = 25^\circ\text{C}^{*2}$	—	—	TBD	m Ω
Internal Gate Resistance	r_g		—	0.85	—	Ω

*1 Represent ratings and characteristics of the anti-parallel, emitter-to-collector free wheeling diode (FWDI).

*2 Case temperature (T_C) and heatsink temperature (T_S) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. The heatsink thermal resistance should be measured just under the chips.

*6 Pulse width and repetition rate should be such as to cause negligible temperature rise.

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Single IGBT Module
 600 Amperes/1700 Volts

Electrical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified (continued)

Thermal Resistance Characteristics

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal Resistance, Junction to Case ^{*2}	$R_{th(j-c)Q}$	Per Inverter IGBT	—	26.8	—	K/kW
Thermal Resistance, Junction to Case ^{*2}	$R_{th(j-c)D}$	Per Inverter FWDi	—	37.9	—	K/kW
Contact Thermal Resistance, Case to Heatsink ^{*2}	$R_{th(c-f)}$	Thermal Grease Applied	—	15	—	K/kW

Mechanical Characteristics

Mounting Torque		Mounting to Terminal, M8 Screw	—	—	95	in-lb
		Mounting to Terminal, M4 Screw	—	—	15	in-lb
		Mounting to Heatsink, M6 Screw	—	—	40	in-lb
Creepage Distance	d_s	Terminal to Terminal	18	—	—	mm
		Terminal to Baseplate	20	—	—	mm
Clearance	d_a	Terminal to Terminal	13	—	—	mm
		Terminal to Baseplate	20	—	—	mm
Weight	m		—	600	—	Grams
Flatness of Baseplate	e_c	On Centerline X, Y	-100	—	+100	μm

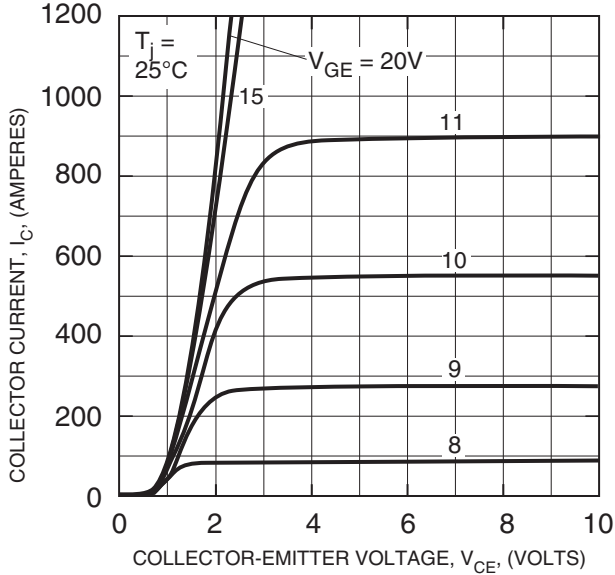
Recommended Operating Conditions, $T_a = 25^\circ\text{C}$

(DC) Supply Voltage	V_{CC}	Applied Across C-E	—	1000	1200	Volts
Gate (-Emitter Drive) Voltage	$V_{GE(on)}$	Applied Across G-E	13.5	15.0	16.5	Volts
External Gate Resistance	R_G	Per Switch	0	—	13.5	Ω

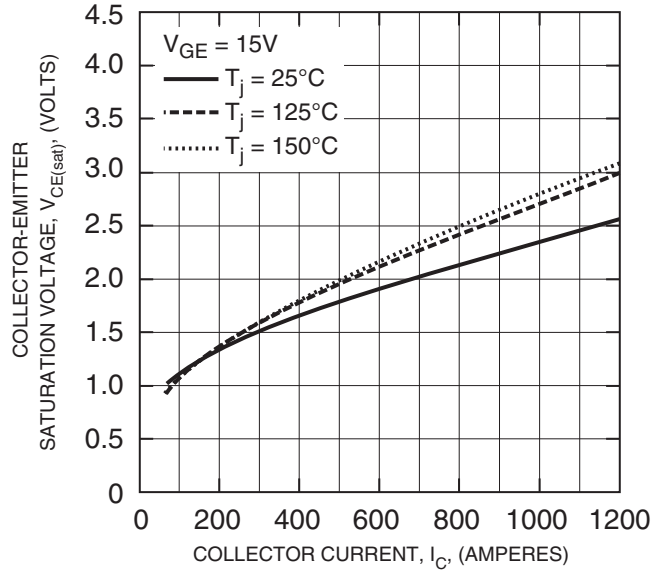
^{*2} Case temperature (T_C) and heatsink temperature (T_S) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. The heatsink thermal resistance should be measured just under the chips.

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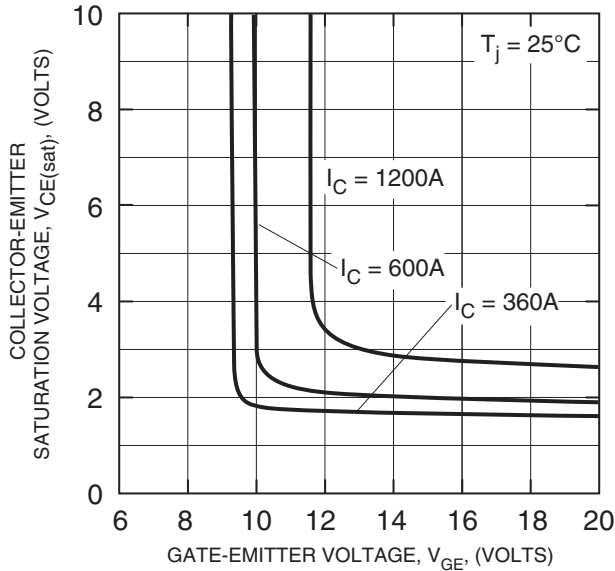
**OUTPUT CHARACTERISTICS
 (CHIP - TYPICAL)**



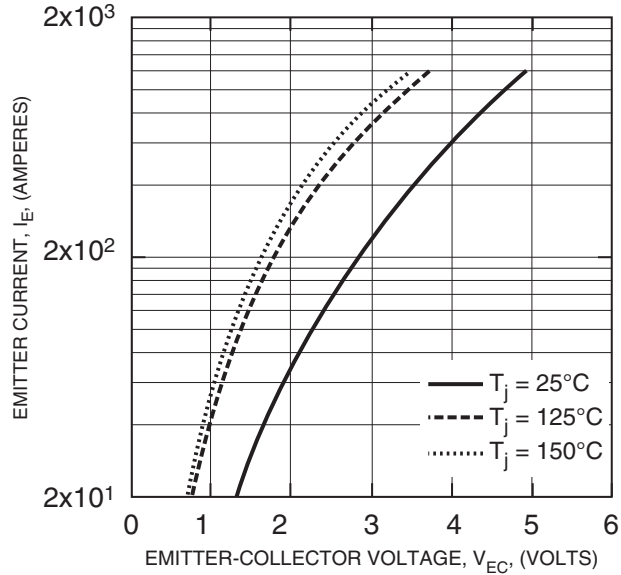
**COLLECTOR-EMITTER
 SATURATION VOLTAGE CHARACTERISTICS
 (CHIP - TYPICAL)**



**COLLECTOR-EMITTER
 SATURATION VOLTAGE CHARACTERISTICS
 (CHIP - TYPICAL)**



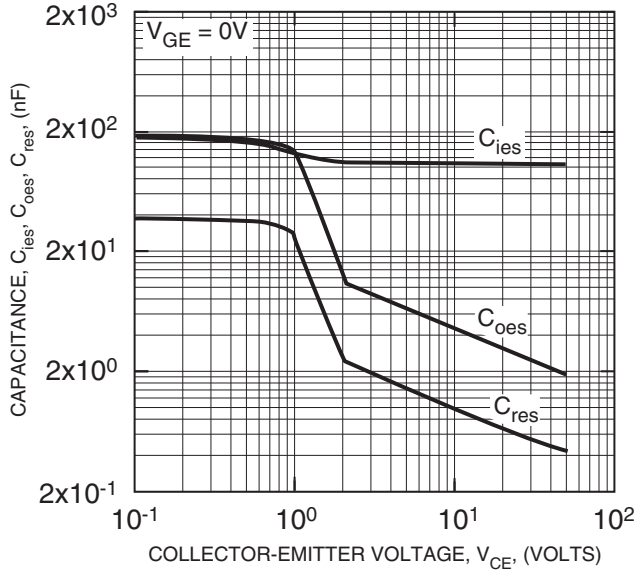
**FREE-WHEEL DIODE
 FORWARD CHARACTERISTICS
 (CHIP - TYPICAL)**



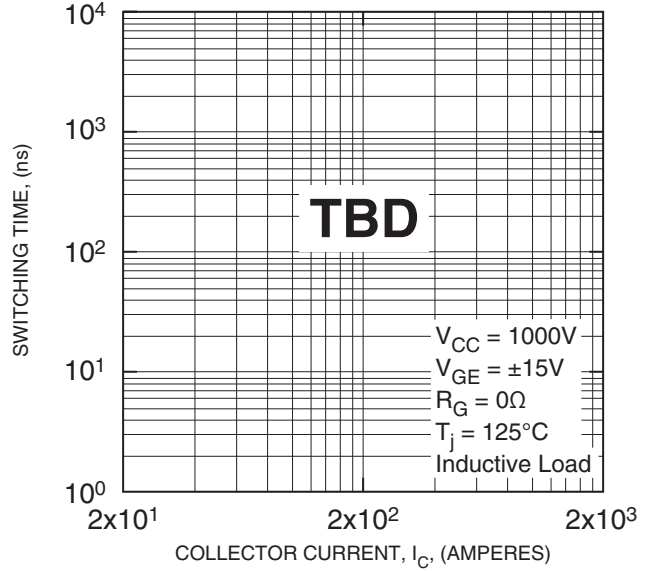
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Single IGBT Module
 600 Amperes/1700 Volts

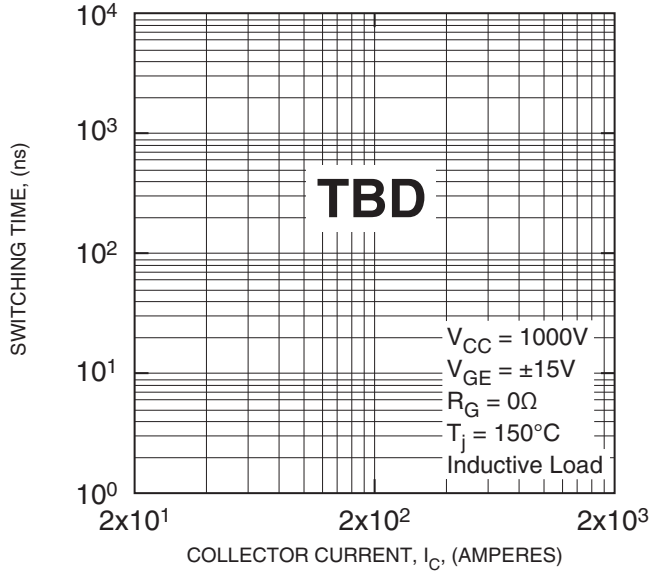
CAPACITANCE VS. V_{CE}
 (TYPICAL)



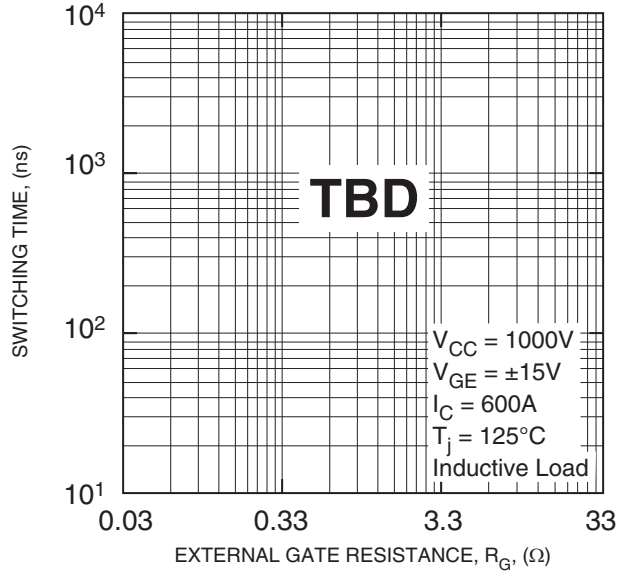
HALF-BRIDGE SWITCHING CHARACTERISTICS
 (TYPICAL)



HALF-BRIDGE SWITCHING CHARACTERISTICS
 (TYPICAL)



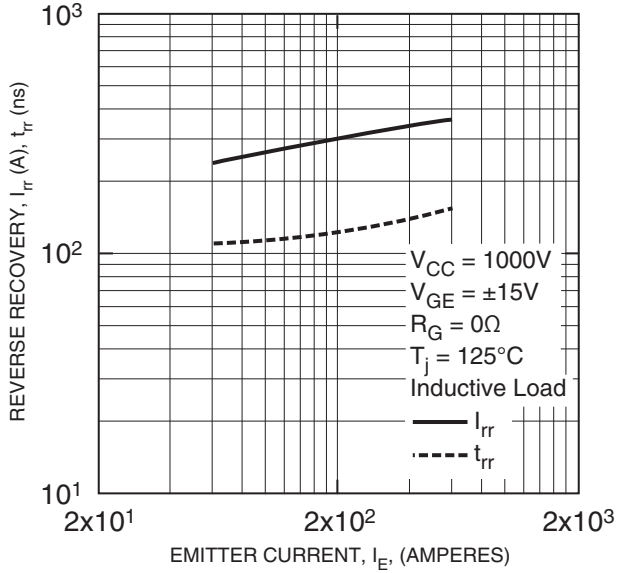
SWITCHING TIME VS. GATE RESISTANCE
 (TYPICAL)



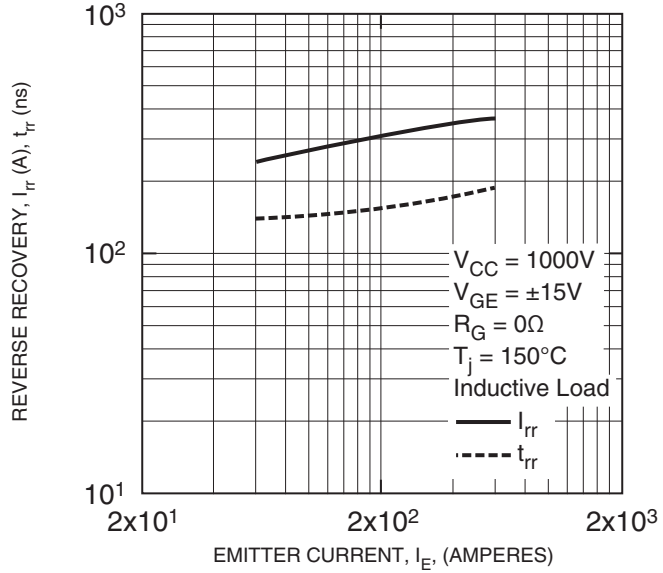
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QIS1760002
 Single IGBT Module
 600 Amperes/1700 Volts

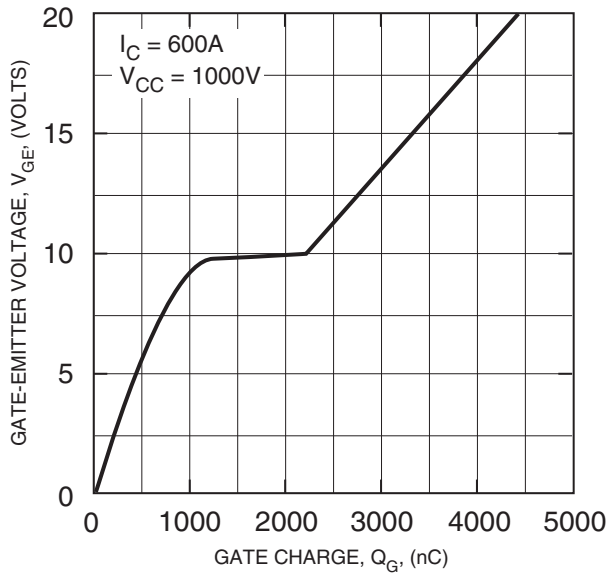
REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



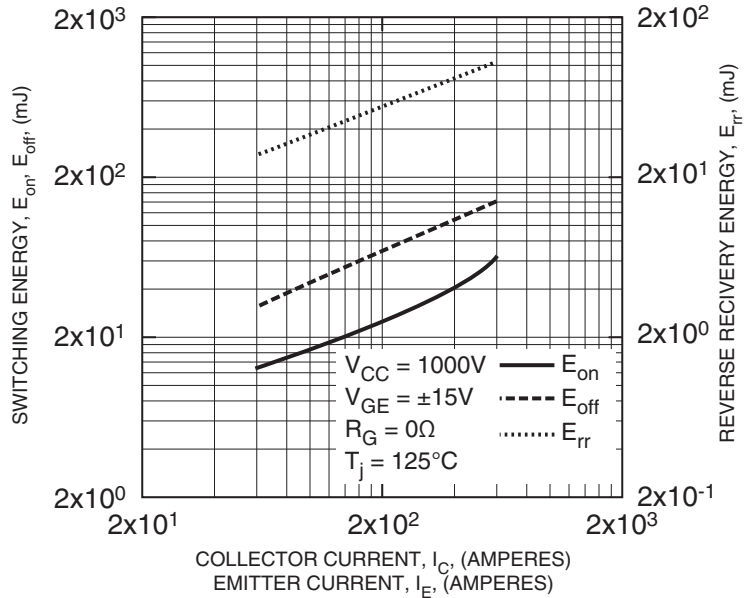
REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



GATE CHARGE VS. V_GE (TYPICAL)



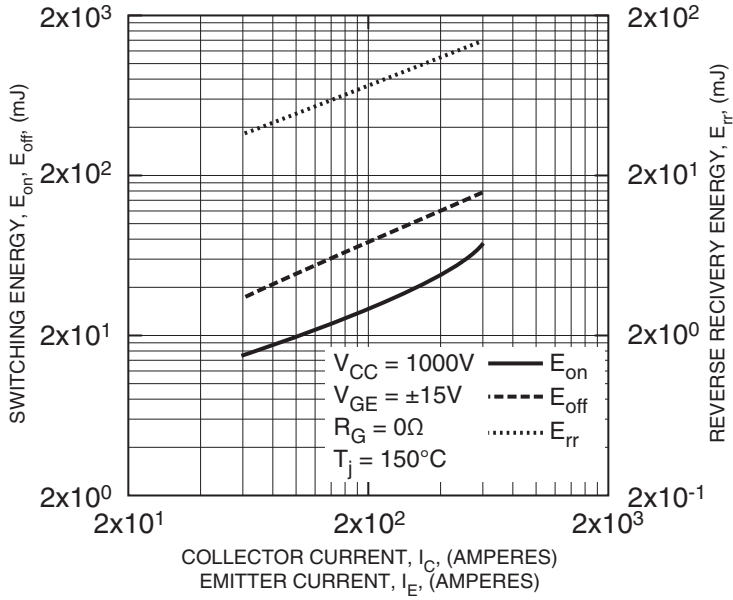
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



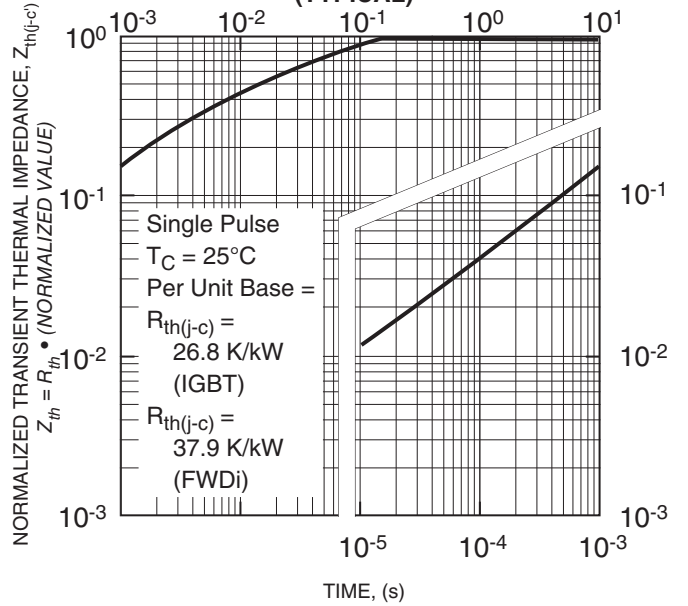
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QIS1760002
 Single IGBT Module
 600 Amperes/1700 Volts

HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (TYPICAL)



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